
Advances In Atomic Spectroscopy Vol 7

ADVANCES IN ATOMIC SPECTROSCOPY VOL 7 - *Advances In Atomic Spectroscopy Vol 7 (FREE)* Atomic force microscopy (AFM) or scanning force microscopy (SFM) is a very-high-resolution type of scanning probe microscopy (SPM), with demonstrated resolution on the order of fractions of a nanometer, more than 1000 times better than the optical diffraction limit.
- Mon, 20 May 2019 12:17:00 GMT Titanium(IV) oxide, anatase nanopowder,